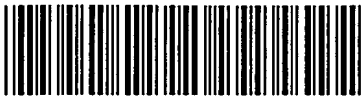


# Search Notes



Application/Control No.

10/083,814

Examiner

Tse Chen

Applicant(s)/Patent under  
Reexamination

MANN ET AL.

Art Unit

2116

## SEARCHED

Class	Subclass	Date	Examiner

## INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

## SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
<i>keep search only</i> <i>see search for prior</i>		<i>TSG</i>